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Application/Control No.	Applicant(s)/Patent und Reexamination	er
10/650,328	KABURAGI ET AL.	
Examiner	Art Unit	<u> </u>
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Anthony H. Nguyen

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SEARCHED			
Class	Subclass	Date	Examiner
399	366,365 361, 79 77, 43	9/24/2005	HAI
Above	Updated	9/24/2005	HAI

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
399	See S.N	9/24/2005	HAI
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